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## FDMQ8203

GreenBridge ${ }^{\text {TM }}$ Series of High-Efficiency Bridge Rectifiers Dual N-Channel and Dual P-Channel PowerTrench ${ }^{\circledR}$ MOSFET
N -Channel: $100 \mathrm{~V}, 6 \mathrm{~A}, 110 \mathrm{~m} \Omega$ P-Channel: - $\mathbf{- 8 0} \mathrm{V},-6 \mathrm{~A}, 190 \mathrm{~m} \Omega$

## Features

Q1/Q4: N-Channel

- $\operatorname{Max} \mathrm{r}_{\mathrm{DS}(\text { on })}=110 \mathrm{~m} \Omega$ at $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=3 \mathrm{~A}$

■ Max $r_{\mathrm{DS}(\text { on })}=175 \mathrm{~m} \Omega$ at $\mathrm{V}_{\mathrm{GS}}=6 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=2.4 \mathrm{~A}$
Q2/Q3: P-Channel

- $\operatorname{Max} r_{\mathrm{DS}(o n)}=190 \mathrm{~m} \Omega$ at $\mathrm{V}_{\mathrm{GS}}=-10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-2.3 \mathrm{~A}$
- Max $r_{\text {DS(on) }}=235 \mathrm{~m} \Omega$ at $\mathrm{V}_{\mathrm{GS}}=-4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-2.1 \mathrm{~A}$
- Substantial efficiency benefit in PD solutions
- RoHS Compliant

General Description
This quad mosfet solution provides ten-fold improvement in power dissipation over diode bridge.

## Application

- High-Efficiency Bridge Rectifiers

Top


MLP 4.5x5
MLP


MOSFET Maximum Ratings $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ unless otherwise noted

| Symbol | Parameter |  |  |  | Q1/Q4 | Q2/Q3 | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {DS }}$ | Drain to Source Voltage |  |  |  | 100 | -80 | V |
| $\mathrm{V}_{\mathrm{GS}}$ | Gate to Source Voltage |  |  |  | $\pm 20$ | $\pm 20$ | V |
| ${ }_{\text {I }}$ | Drain Current | -Continuous (Package limited) | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ |  | 6 | -6 | A |
|  |  | -Continuous (Silicon limited) | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ |  | 10 | -10 |  |
|  |  | -Continuous | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ | (Note 1a) | 3.4 | -2.6 |  |
|  |  | -Pulsed |  |  | 12 | -10 |  |
| $\mathrm{P}_{\mathrm{D}}$ | Power Dissip | n for Single Operation | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ |  | 22 | 37 | W |
|  | Power Dissip | for Dual Operation | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ | (Note 1a) | 2.5 |  |  |
| $\mathrm{T}_{\mathrm{J},}, \mathrm{T}_{\text {STG }}$ | Operating and Storage Junction Temperature Range |  |  |  | $-55 \text { to }+150$ |  | ${ }^{\circ} \mathrm{C}$ |

Thermal Characteristics

| $\mathrm{R}_{\theta \mathrm{JA}}$ | Thermal Resistance, Junction to Ambient | (Note 1a) | 50 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| :--- | :--- | :---: | :---: | :---: |
| $\mathrm{R}_{\theta \mathrm{JA}}$ | Thermal Resistance, Junction to Ambient | (Note 1b) | 160 |  |

## Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
| :---: | :---: | :---: | :---: | :---: | :---: |
| FDMQ8203 | FDMQ8203 | MLP4.5x5 | 13 " | 12 mm | 3000 units |

Electrical Characteristics $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Type | Min | Typ | Max | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Off Characteristics |  |  |  |  |  |  |  |
| $B V_{\text {DSS }}$ | Drain to Source Breakdown Voltage | $\begin{aligned} & \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V} \\ & \mathrm{I}_{\mathrm{D}}=-250 \mu \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V} \end{aligned}$ | $\begin{aligned} & \text { Q1/Q4 } \\ & \text { Q2/Q3 } \end{aligned}$ | $\begin{gathered} 100 \\ -80 \end{gathered}$ |  |  | V |
| $\frac{\Delta \mathrm{BV}_{\mathrm{DSS}}}{\Delta \mathrm{~T}_{\mathrm{J}}}$ | Breakdown Voltage Temperature Coefficient | $\mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$, referenced to $25^{\circ} \mathrm{C}$ <br> $\mathrm{I}_{\mathrm{D}}=-250 \mu \mathrm{~A}$, referenced to $25^{\circ} \mathrm{C}$ | $\begin{aligned} & \text { Q1/Q4 } \\ & \text { Q2/Q3 } \end{aligned}$ |  | $\begin{gathered} 72 \\ -79 \end{gathered}$ |  | $\mathrm{mV} /{ }^{\circ} \mathrm{C}$ |
| $\mathrm{I}_{\text {DSS }}$ | Zero Gate Voltage Drain Current | $\begin{aligned} & \mathrm{V}_{\mathrm{DS}}=80 \mathrm{~V}, \quad \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{DS}}=-64 \mathrm{~V}, \quad \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V} \end{aligned}$ | $\begin{aligned} & \text { Q1/Q4 } \\ & \text { Q2/Q3 } \end{aligned}$ |  |  | $\begin{gathered} 1 \\ -1 \end{gathered}$ | $\begin{aligned} & \mu \mathrm{A} \\ & \mu \mathrm{~A} \end{aligned}$ |
| $\mathrm{I}_{\text {GSS }}$ | Gate to Source Leakage Current | $\mathrm{V}_{\mathrm{GS}}= \pm 20 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=0 \mathrm{~V}$ | $\begin{aligned} & \text { Q1/Q4 } \\ & \text { Q2/Q3 } \end{aligned}$ |  |  | $\begin{aligned} & \pm 100 \\ & \pm 100 \end{aligned}$ | $\begin{aligned} & \mathrm{nA} \\ & \mathrm{nA} \end{aligned}$ |

## On Characteristics

| $\mathrm{V}_{\mathrm{GS}(\mathrm{th})}$ | Gate to Source Threshold Voltage | $\begin{aligned} & \mathrm{V}_{\mathrm{GS}}=\mathrm{V}_{\mathrm{DS}}, \quad \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A} \\ & \mathrm{~V}_{\mathrm{GS}}=\mathrm{V}_{\mathrm{DS}}, \mathrm{I}_{\mathrm{D}}=-250 \mu \mathrm{~A} \end{aligned}$ | $\begin{aligned} & \text { Q1/Q4 } \\ & \text { Q2/Q3 } \end{aligned}$ | $\begin{gathered} \hline 2 \\ -1 \end{gathered}$ | $\begin{gathered} \hline 3 \\ -1.6 \end{gathered}$ | $\begin{gathered} 4 \\ -3 \end{gathered}$ | V |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\frac{\Delta \mathrm{V}_{\mathrm{GS}(\text { th })}}{\Delta \mathrm{T}_{\mathrm{J}}}$ | Gate to Source Threshold Voltage Temperature Coefficient | $\mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$, referenced to $25^{\circ} \mathrm{C}$ $\mathrm{I}_{\mathrm{D}}=-250 \mu \mathrm{~A}$, referenced to $25^{\circ} \mathrm{C}$ | $\begin{aligned} & \text { Q1/Q4 } \\ & \text { Q2/Q3 } \end{aligned}$ |  | $\begin{gathered} -8 \\ 5 \end{gathered}$ |  | $\mathrm{mV} /{ }^{\circ} \mathrm{C}$ |
| $\mathrm{r}_{\text {DS(on) }}$ | Drain to Source On Resistance | $\begin{aligned} & \mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=3 \mathrm{~A} \\ & \mathrm{~V}_{\mathrm{GS}}=6 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=2.4 \mathrm{~A} \\ & \mathrm{~V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=3 \mathrm{~A}, \mathrm{~T}_{\mathrm{J}}=125^{\circ} \mathrm{C} \end{aligned}$ | Q1/Q4 |  | $\begin{gathered} \hline 85 \\ 118 \\ 147 \end{gathered}$ | $\begin{aligned} & 110 \\ & 175 \\ & 191 \end{aligned}$ | $\mathrm{m} \Omega$ |
|  |  | $\begin{aligned} & \mathrm{V}_{G S}=-10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-2.3 \mathrm{~A} \\ & \mathrm{~V}_{G S}=-4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-2.1 \mathrm{~A} \\ & \mathrm{~V}_{G S}=-10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-2.3 \mathrm{~A}, \mathrm{~T}_{\mathrm{J}}=125^{\circ} \mathrm{C} \end{aligned}$ | Q2/Q3 |  | $\begin{aligned} & 161 \\ & 188 \\ & 273 \end{aligned}$ | $\begin{aligned} & 190 \\ & 235 \\ & 323 \end{aligned}$ |  |
| $\mathrm{gFS}^{\text {S }}$ | Forward Transconductance | $\begin{aligned} & \mathrm{V}_{\mathrm{DS}}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=3 \mathrm{~A} \\ & \mathrm{~V}_{\mathrm{DS}}=-10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-2.3 \mathrm{~A} \end{aligned}$ | $\begin{aligned} & \text { Q1/Q4 } \\ & \text { Q2/Q3 } \end{aligned}$ |  | $\begin{aligned} & 6 \\ & 6 \end{aligned}$ |  | S |

## Dynamic Characteristics

| $\mathrm{C}_{\text {iss }}$ | Input Capacitance | Q1/Q4: $\mathrm{V}_{\mathrm{DS}}=50 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{f}=1 \mathrm{MHZ}$ <br> Q2/Q3: $\mathrm{V}_{\mathrm{DS}}=-40 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{f}=1 \mathrm{MHZ}$ | $\begin{aligned} & \text { Q1/Q4 } \\ & \text { Q2/Q3 } \end{aligned}$ | $\begin{aligned} & 158 \\ & 639 \end{aligned}$ | $\begin{aligned} & 210 \\ & 850 \end{aligned}$ | pF |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Coss | Output Capacitance |  | $\begin{aligned} & \text { Q1/Q4 } \\ & \text { Q2/Q3 } \end{aligned}$ | $\begin{aligned} & 41 \\ & 46 \end{aligned}$ | 55 65 | pF |
| $\mathrm{Crss}^{\text {r }}$ | Reverse Transfer Capacitance |  | $\begin{aligned} & \text { Q1/Q4 } \\ & \text { Q2/Q3 } \end{aligned}$ | $\begin{aligned} & 2.6 \\ & 24 \end{aligned}$ | 5 40 | pF |

## Switching Characteristics

| $\mathrm{t}_{\mathrm{d} \text { (on) }}$ | Turn-On Delay Time | Q1/Q4: $\begin{aligned} & \mathrm{V}_{\mathrm{DD}}=50 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=3 \mathrm{~A}, \\ & \mathrm{~V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{R}_{\mathrm{GEN}}=6 \Omega \end{aligned}$ <br> Q2/Q3: <br> $V_{D D}=-40 \mathrm{~V}, I_{D}=-2.3 \mathrm{~A}$, $V_{G S}=-10 \mathrm{~V}, \mathrm{R}_{\mathrm{GEN}}=6 \Omega$ | $\begin{array}{\|l\|} \hline \text { Q1/Q4 } \\ \text { Q2/Q3 } \end{array}$ | 3.8 4.7 | 10 10 | ns |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{t}_{\mathrm{r}}$ | Rise Time |  | $\begin{array}{\|l\|} \hline \text { Q1/Q4 } \\ \text { Q2/Q3 } \\ \hline \end{array}$ | $\begin{aligned} & 1.3 \\ & 2.8 \end{aligned}$ | $\begin{aligned} & 10 \\ & 10 \end{aligned}$ | ns |
| $\mathrm{t}_{\mathrm{d} \text { (off) }}$ | Turn-Off Delay Time |  | $\begin{array}{\|l\|} \hline \text { Q1/Q4 } \\ \text { Q2/Q3 } \end{array}$ | 7.5 22 | 15 35 | ns |
| $\mathrm{t}_{\mathrm{f}}$ | Fall Time |  | $\begin{array}{\|l\|} \hline \text { Q1/Q4 } \\ \text { Q2/Q3 } \end{array}$ | 1.9 2.7 | 10 10 | ns |
| $\mathrm{Q}_{\mathrm{g}}$ | Total Gate Charge | VGS $=0 \mathrm{~V}$ to 10 V  <br> VGS $=0 \mathrm{~V}$ to -10 V Q1/Q4:  | $\begin{array}{\|l\|} \hline \text { Q1/Q4 } \\ \text { Q2/Q3 } \end{array}$ | 2.9 13 | 5 19 | nC |
| $\mathrm{Q}_{\mathrm{g}}$ | Total Gate Charge | $\mathrm{VGS}=0 \mathrm{~V}$ to 5 VVGS $=0 \mathrm{~V}$ to -4.5 V$\mathrm{V} \mathrm{DD}=50 \mathrm{~V}$, <br> $\mathrm{I}_{\mathrm{D}}=3 \mathrm{~A}$ | $\begin{array}{\|l\|} \hline \text { Q1/Q4 } \\ \text { Q2/Q3 } \end{array}$ | $\begin{aligned} & 1.6 \\ & 6.4 \end{aligned}$ | $\begin{gathered} \hline 3 \\ 10 \end{gathered}$ | nC |
| Qgs | Gate to Source Gate Charge | Q2/Q3: $V_{D D}=-40 \mathrm{~V},$ | $\begin{array}{\|l\|} \hline \text { Q1/Q4 } \\ \text { Q2/Q3 } \\ \hline \end{array}$ | $\begin{aligned} & \hline 0.8 \\ & 1.6 \end{aligned}$ |  | nC |
| Qgd | Gate to Drain "Miller" Charge |  | $\begin{array}{\|l\|} \hline \text { Q1/Q4 } \\ \text { Q2/Q3 } \\ \hline \end{array}$ | $\begin{aligned} & \hline 0.8 \\ & 2.6 \\ & \hline \end{aligned}$ |  | nC |

Electrical Characteristics $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Type | Min | Typ | Max | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Drain-Source Diode Characteristics |  |  |  |  |  |  |  |
| $V_{\text {SD }}$ | Source to Drain Diode Forward Voltage | $V_{G S}=0 \mathrm{~V}, I_{S}=3 \mathrm{~A}$ $($ Note 2) <br> $V_{G S}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{S}}=-2.3 \mathrm{~A}$ $($ Note 2) | $\begin{aligned} & \text { Q1/Q4 } \\ & \text { Q2/Q3 } \end{aligned}$ |  | $\begin{gathered} 0.86 \\ -0.82 \end{gathered}$ | $\begin{gathered} 1.3 \\ -1.3 \end{gathered}$ | V |
| $\mathrm{t}_{\mathrm{rr}}$ | Reverse Recovery Time | $\begin{aligned} & \text { Q1/Q4: } \\ & \mathrm{I}_{\mathrm{F}}=3 \mathrm{~A}, \mathrm{di} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s} \\ & \text { Q2/Q3: } \\ & \mathrm{I}_{\mathrm{F}}=-2.3 \mathrm{~A}, \mathrm{di} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s} \end{aligned}$ | $\begin{aligned} & \text { Q1/Q4 } \\ & \text { Q2/Q3 } \end{aligned}$ |  | $\begin{aligned} & 32 \\ & 26 \end{aligned}$ | $\begin{aligned} & 52 \\ & 42 \end{aligned}$ | ns |
| $\mathrm{Q}_{\text {rr }}$ | Reverse Recovery Charge |  | $\begin{aligned} & \text { Q1/Q4 } \\ & \text { Q2/Q3 } \end{aligned}$ |  | $\begin{aligned} & 21 \\ & 26 \end{aligned}$ | $\begin{aligned} & 34 \\ & 42 \end{aligned}$ | nC |

Notes:
1: $R_{\theta J A}$ is determined with the device mounted on a $1 \mathrm{in}^{2}$ pad 2 oz copper pad on a $1.5 \times 1.5 \mathrm{in}$. board of FR-4 material. $R_{\theta J C}$ is guaranteed by design while $R_{\theta C A}$ is determined by the user's board design.

a. $50^{\circ} \mathrm{C} / \mathrm{W}$ when mounted on a $1 \mathrm{in}^{2}$ pad of 2 oz copper, the board designed Q1+Q3 or Q2+Q4.

b. $160{ }^{\circ} \mathrm{C} / \mathrm{W}$ when mounted on a minimum pad of 2 oz copper, the board designed Q1+Q3 or Q2+Q4

2: Pulse Test: Pulse Width $<300 \mu$ s, Duty cycle $<2.0 \%$.

Typical Characteristics (N-Channel) $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ unless otherwise noted


Figure 1. On Region Characteristics


Figure 3. Normalized On Resistance vs Junction Temperature


Figure 5. Transfer Characteristics


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage


Figure 4. On-Resistance vs Gate to Source Voltage


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics (N-Channel) $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ unless otherwise noted


Figure 7. Gate Charge Characteristics


Figure 9. Forward Bias Safe Operating Area


Figure8. CapacitancevsDrain to Source Voltage

Typical Characteristics (P-Channel) $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ unlenss otherwise noted


Figure 10. On-Region Characteristics


Figure 12. Normalized On-Resistance vs Junction Temperature


Figure 14. Transfer Characteristics


Figure 11. Normalized on-Resistance vs Drain Current and Gate Voltage


Figure 13. On-Resistance vs Gate to Source Voltage


Figure 15. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics (P-Channel) $\mathrm{T}_{J}=25^{\circ} \mathrm{C}$ unlenss otherwise noted


Figure 16. Gate Charge Characteristics



Figure 17. Capacitance vs Drain to Source Voltage

Figure 18. Forward Bias Safe Operating Area

Typical Characteristics $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ unlenss otherwise noted


Figure 19. Single Pulse Maximum Power Dissipation


Figure 20. Junction-to-Ambient Transient Thermal Response Curve

## Dimensional Outline and Pad Layout




#### Abstract

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